Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination HAYKO ET AL.

Examiner

Michael S. A. Delgado

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Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,701,441	03-2004	Balasubramaniam et al.	713/201
`	В	US-6,516,346	02-2003	Asco et al.	709/221
	С	US-6,347,398	02-2002	Parthasarathy et al.	717/178
	D	US-6,675,382	01-2004	Foster, Gary D.	717/177
	E	US-6,067,416	05-2000	Fraser, Robert E.	717/178
	F	US-6,675,381	01-2004	Yamaguchi, Tomohisa	717/168
	G	US-6,314,565	11-2001	Kenner et al.	717/171
	Н	US-6,074,434	06-2000	Cole et al.	717/173
	1	US-6,606,744	08-2003	Mikurak, Michael G.	717/174
	J	US-	:		
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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